Substitute, for form 1449/PTO & 1449B/PTO

## FOURTH INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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Complete if Known		1 8 2008	
Application Number	10/635,716	Vbk To so B	
Filing Date	August 7, 2003	(A) LE	
First Named Inventor	Akihiko Umeno et al.		
Examiner Name	Michael Apanius		
Attorney Docket No.	1011350-000317		

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Enter Office that issued the document, by the two-letter code.											

Examiner Initials

Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.

Notice of Reason for Refusal issued in corresponding Japanese Patent Application No. 2003-156011 (w/English Translation) dated December 18, 2007.

\*Patent Family List Provided

Examiner Signature	Date Considered
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